

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/757,364	CHAN ET AL.	
Examiner		John T. Haran	Art Unit	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,133,066	10-2000	Murakami, Tomoo	438/108
	B	US-6,207,475	03-2001	Lin et al.	438/108
	C	US-6458472	10-2002	Konarski et al	428/620
	D	US-6467676	10-2002	Wang	228/180.22
	E	US-5,334,260	08-1994	Stefanowski, Krystyna	228/223
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.